

Notice of References Cited

Application/Control No.

10/564,745

Applicant(s)/Patent Under
Reexamination
TAKAYAMA ET AL.

Examiner

Michael Szperka

Art Unit

1644

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2003054020 A2	07-2003	World Intellect	FARNDALÉ et al.	
	O					
	P					
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NON-PATENT DOCUMENTS

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